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Application/Control No.	Applicant(s)/Patent under Reexamination
09/751,391	LEE ET AL.
Examiner	Art Unit
Naeem Haq	3625

	SEARCHED		
Class	Subclass	Date	Examiner
705	26,27		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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